

Reference Material Certificate

512/02

Aluminium Base (Type of Standard)
AlMg, Set 510

Certified Values

Element	Mass content [%]	Uncertainty [%]
Silicon (Si)	0.0377	± 0.0015
Iron (Fe)	0.0306	± 0.0015
Copper (Cu)	0.0126	± 0.0005
Manganese (Mn)	0.0107	± 0.0005
Magnesium (Mg)	0.498	± 0.008
Chromium (Cr)	0.0107	± 0.0005
Nickel (Ni)	0.0117	± 0.0007
Zinc (Zn)	0.0116	± 0.0008
Titanium (Ti)	0.0135	± 0.0005
Arsenic (As)	0.0016	± 0.0003
Beryllium (Be)	0.00092	± 0.00007
Cadmium (Cd)	0.0010	± 0.0001
Gallium (Ga)	0.0042	± 0.0003
Mercury (Hg)	0.0036	± 0.0004
Lead (Pb)	0.00126	± 0.00015
Antimony (Sb)	0.0014	± 0.0002
Tin (Sn)	0.0012	± 0.0002
Vanadium (V)	0.0057	± 0.0004
Zirconium (Zr)	0.0052	± 0.0004

The uncertainty reported is the result of standard deviation of all results multiplied with a factor of two and represents approximately the 95% confidence interval.

Manufacturing

This standard is produced using six strand hot top vertical continuous casting out of single melt.

Homogeneity

Homogeneity testing is performed by means of spark emission spectroscopy. Tests involve making multiple measurements on individual samples taken at regular intervals along the entire length of each cast rod. Depending on the mass content of the element, the relative standard deviation of multiple measurements between discs or within one disc is typically found between 0.3% - 1% for alloying and other elements and 0.5% - 5% for trace elements.

Analysis

The values listed in this analysis certificate are the results of multiple analyses performed in our chemical analysis laboratory which is an accredited test facility for aluminium alloys according to the international standard ISO 17025. The analyses are based on established wet chemical procedures.

Description of Sample

This reference material is available in the form of discs (approx. \varnothing 60 x 25 mm).

Intended use and Stability

This certified reference material is primarily intended for use in spark optical emission spectroscopy. Other applications are X-ray fluorescence spectrometry (XRF) and classical wet chemical procedures. The minimum sample size for wet chemical analysis is 0.2g. The material will remain stable for the period given below (certification validity) if it is stored in a dry and clean environment at room temperature.

Instructions for Use

Calibration measurements should be made within a ring between 2mm and 22mm from the edge of the CRM face. For wet chemical analysis chips have to be prepared by turning or milling of the sample surface.



Traceability

Traceability of the certified mass contents to the SI (Système International d'Unités) is ensured by calibration using certified standard solutions or pure metals or substances of known stoichiometry.

Dr. Benedikt Moser
CTO

Patrik Bachmann
Head of Inorganic Analytics

Suisse Technology Partners Ltd.
Querstrasse 5
8212 Neuhausen am Rheinfall
Switzerland

Phone: +41 52 551 11 00
Fax : +41 52 551 11 99
Email: refmat@suisse-tp.ch
Internet: <https://reference-materials.ch>

Date of certification: 4-Nov-1993
Certificate version 004: 04-Jan-2022
This certificate is valid until: Nov-2068